Notice of References Cited Application/Control No. 10/799,081 Examiner John R. Hardee 1751 Applicant(s)/Patent Under Reexamination ABE ET AL. Page 1 of 1 U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification			
*	Α	US-2002/0144356	10-2002	Kawai et al.	8/405			
	В	US-						
	С	US-						
	D	US-						
	Ε	US-						
	F	US-						
	G	US-						
	Н	US-						
	-	US-						
	J	US-			,			
	К	US-						
	L	US-						
	М	US-						

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
_	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	w	
	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.